Complete if Known 10/560.488 Application Number INFORMATION DISCLOSURE Filing Date December 12, 2005 First Named Inventor Gerald Lucovsky STATEMENT BY APPLICANT Confirmation No. 3119 Examiner Name Benjamin P. Sandvik (use as many sheets as necessary) Attorney Docket Number 5051-639 Sheet A1 A1

Examiner Initials*	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited	Date of Publication of Cited Document
		Number	Kind Code (if known)	Document	MM-DD-YYYY
	1.	2002/0197789	A1	Buchanan et al;	12/26/2002

FOREIGN PATENT DOCUMENTS Translation Foreign Patent Document Name of Patentee or Applicant of Cited Date of Examiner Cite Document Publication of Initials* No. Office Number Kind Code Cited (if known) Document MM-DD-YYYY

Examiner Initials*	Cite No.	serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			
	2.	Woo Sik Kim: Ferroelectric-gate field effect transistors using Nd₂Ti₂O ₇ /Y₂O₃/Si structures; Thin Solid Films 398-399 (2001) 663-667.			
	3.	Seung-Gu Lim; Dielectric functions and optical bandgaps of high-K dielectrics for metal-oxide- semicondutor field-effect transistors by far ultraviolet spectroscopic ellipsometry; Journal of Applied Physics, Volume: 91, Number 7, pp 4500-4505 (April 1, 2002).			
	4.	J.K. Yamamoto, Microwave dielectric properties of layered perovskite A₂B₂O₁ single-crystal fibers; Elsevier Science Publishers B.V. (North-Holland (1991) Material Letters No. 11/12 pp 497-500.			
	5.	European communication with European Search Report for Application No. 04776548.2 – 1235 PCT/US2004018863, dated 5-6-2008.			

Examiner Signature	/Benjamin Sandvik/ (09/03/2008)	Date Considered	